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Sensors & Actuators: B. Chemical 373 (2022) 132646

The publisher's version is available at:

https://doi.org/10.1016/j.snb.2022.132646

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## Modelling electronic transport in monocrystalline metal oxide gas sensors: from the surface kinetics to the experimental response

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#### Abstract

Gas sensing systems and devices based on metal oxides are widely spreading due to their high performance in terms of sensor response and relatively low costs. Despite several experimental studies, as well as molecular simulations, are available in the literature, a tool that can quickly predict the macroscopic sensor response, and potentially be used for predictive purposes, is still missing.

In this work, we present a modelling approach based on finite-element simulations, using material electrical properties available in the literature. In a first approach, we derive the surface electron trap concentration from fitting the global sensor response. Then, we improve the model by eliminating this fitting and considering the actual timedependent experimental response. We consider sensors based on single  $SnO_2$ nanowires and show how our model predicts with a good agreement the experimental response *vs.*  $NO_2$ , as a function of the working temperature and gas concentration, and also provides many other physical quantities of interest, such as the conduction band edge bending, the space charge and the width of the depletion layer. We further discuss ideas for improving the model and thus increasing its predictive potential.

#### Keywords

Gas sensors; metal oxides; sensor response; numerical simulations; multiscale modelling; NO<sub>2</sub> sensors.

#### **1** Introduction

Gas-sensing systems are widely employed in a variety of industrial, environmental and biomedical applications. The majority of gas sensors available on the market relies on Metal OXides (MOX), whose response characteristics are based on the variation of the electrical conductivity as function of the gas concentrations and are known since the 1960s [1].

In recent years, thanks to the advances in micro- and nanofabrication technologies, nanostructured metal oxide-based gas sensors have been developed [2,3]. Thanks to an increased surface-to-volume ratio, in fact, they present an enhanced response to various gaseous environments [4-7]. Single nanowire-based devices look extremely promising from this point of view, since the absence of grain boundaries allows for a higher base current which provides improved performance [8,9] and selectivity [10]. Nitrogen dioxide (NO<sub>2</sub>) is a toxic and pollutant gas that still exceeds, in many areas across the world, the limits allowed by national and supranational laws [11]. Automotive and industrial emissions are the main NO<sub>2</sub> outdoor sources. It is an air pollutant since it can be associated with severe diseases, such as asthma, lung cancer, and cardiovascular problems [12]. The 15 min - Short Term Exposure Level (STEL) recommended by the Scientific Committee of the European Commission on Occupational Exposure Limits (SCOEL) for NO<sub>2</sub> is 1 ppm. Recently, several works were focused on the development of new sensing materials for the detection of NO<sub>2</sub>, owing to the dangerousness of this toxic gas [13,14]. Among them, SnO<sub>2</sub> nanowires

showed excellent sensing properties, including high sensing response and good selectivity [15].

The modelling and prediction of the response of semiconductor gas sensors is not trivial and is only partially addressed in the literature. As displayed in Fig. 1, the interaction of a gas with a sensing structure/device is a highly multiscale phenomenon, i.e. it involves different length and time scales, spanning from chemical sub-molecular interactions to the physical manufacturing of the semiconductor and the experimental data acquisition. Several research works are focused on *ab initio* approaches (see, e.g., Refs. [16,17]) or, sometimes, on molecular dynamics (MD) simulations (see, e.g., Refs. [18,19]). Due to their complexity and usually excessive computational cost, these methods can hardly be used as predictive tools or, from an engineering perspective, for designing (and manufacturing) gas sensors.

Therefore, a modelling "brick" linking the molecular behaviour of the sensing structure(s) to the macroscale (i.e. experimental response) is still missing. However, some authors have tried to develop semi-analytical methods for bridging this gap. Barsan *et al.*, for instance, have developed models for capturing the relationship between the conductivity of metal oxide-based sensing layers and the concentration of chemical species. These models have been specifically proposed for nanostructured materials, where the inter-grain contact resistance is taken into account [20,21]. Other Authors, instead, have provided a numerical solution to the Poisson-Boltzmann's equation, with particular choices for the boundary conditions, and applied it to SnO<sub>2</sub> nanowires [22]. Nevertheless, there is still a lack of a comprehensive model for the response of gas sensors, based on a single MOX nanowire, to a specific target gas. In addition, the complexity of physico-chemical phenomena involved in the sensing mechanism obstacles the realisation and the experimental validation of analytical models.

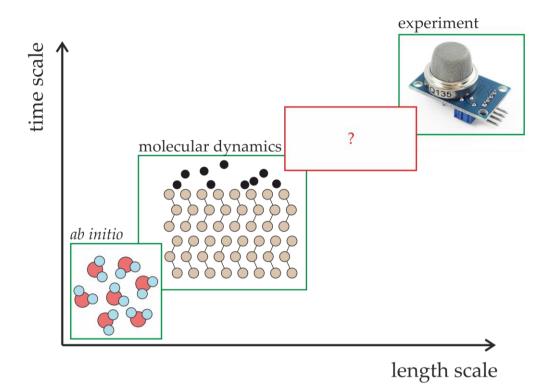


Figure 1: Multiscale approach in gas sensor modelling and missing "brick".

A few recent simulation works have tried to deal with complete MOX gas sensors, but they lack either the prediction of the macroscopic sensor response [23] or the study of the electronic properties [24]. Powroznik *et al.*, instead, have followed a route based on *ab initio* semi-empirical simulations in order to describe the response of H<sub>2</sub>Pc/Pd/PdO structures [25].

In order to correctly predict the response of MOX gas sensors, as well as to optimise their performance, it is therefore necessary to develop multiscale models that allow to describe not only the physical/chemical behaviour at the smallest scale, but also to provide a link to the experimental response. In this sense, modelling the electronic transport with "macroscopic" numerical simulations, e.g. based on the finite-element method, can be a powerful tool for considering many physical and technological parameters, as well as for predicting the experimental sensor response linking it to basic physical quantities such as space charge, carrier density, and conduction band bending.

This paper presents a novel modelling approach to MOX gas sensors, specifically tested on SnO<sub>2</sub> single-nanowire sensors, based on finite-element simulations. On one hand, we employ material parameters available in the literature, e.g. extracted from (*ab initio* and/or molecular dynamics) simulations of MOX nanostructures. On the other

hand, we extract from the experimental data a few additional macroscopic material parameters, such as the carrier mobility and concentration. In this way, we are able to reproduce the response of SnO<sub>2</sub> nanowires with different diameters, by using one fitting parameter, namely the surface electron trap concentration that emulates the occupied NO<sub>2</sub> adsorption sites. In the second part of the paper, we present an improved model by using an actual experimental time-dependent sensor response to extract such trap concentration. This allows the simulation of SnO<sub>2</sub> sensor response without any fitting parameter. Our model has the advantage of being accurate and close to reality, thanks to the direct solution of the drift-diffusion equations coupled with the Poisson's one.

#### 2 Experimental and model details

#### 2.1 Background on experimental data and original results

The experimental data used for comparison with the proposed model are those presented in [9]. The SnO<sub>2</sub> nanowires were grown by chemical vapour deposition in a guartz tube into a horizontal furnace. Pure tin powder and a flow of oxygen were used as sources for the nanowire growth, following the vapour-liquid-solid (VLS) mechanism. A thin layer of Au on SiO<sub>2</sub>/Si substrates was used as a catalyst for the growth of the nanowires. The growth temperature controlled the size of the gold droplets and thus the diameter of the nanowires. Morphological and structural characterizations by means of X-Ray Diffraction (XRD), Scanning Electron Microscopy High-Resolution Transmission Electron (SEM) Microscopy (HRTEM) and demonstrated that SnO<sub>2</sub> nanowires were monocrystalline, without amorphous layers or impurities, and exhibited a large length-to-diameter ratio, as well as a constant diameter. Some nanowires from the same growth process were isolated and contacted at their ends with Ti/Au electrodes, to form chemiresistive sensors. Five sensors based on individual SnO<sub>2</sub> nanowires with different diameters (from 40 to 120 nm, approximately) were tested at different working temperatures towards different concentrations of NO<sub>2</sub> (Fig. 2a). The comparison between the performance of the various sensors, whose only difference was the diameter of the nanowire, made it possible to experimentally test for the first time the detection mechanism called "depletion layer modulation model". The experimental results clearly showed that the sensor response increased as the diameter of the nanowire composing it decreased

(Fig. 2b). The response and recovery times, on the other hand, decreased with the working temperature, but it seems that they were not influenced by the diameter of the nanowires (Fig. 2c).

In that work a simple approximation of the bending of the energy bands with a stepwise function was used, considering the outer annular region of the nanowire as completely depleted of electrons, and the inner cylindrical region as unaffected by gas adsorption. The experimental responses of the different sensors were fitted for all the measured gas concentrations, obtaining seven different estimates of the depletion depth (Fig. 2d). All the estimates obtained were in good agreement with a depletion depth of about 13 nm, compatible with the theoretical values in the literature [26,27]. Despite it, these values were obtained by using a very rough approximation. The aim of this work, therefore, is to develop an affordable and reproducible model able to overcome the approximation above-mentioned, and that can be used to predict the sensing performance of MOX gas sensors.

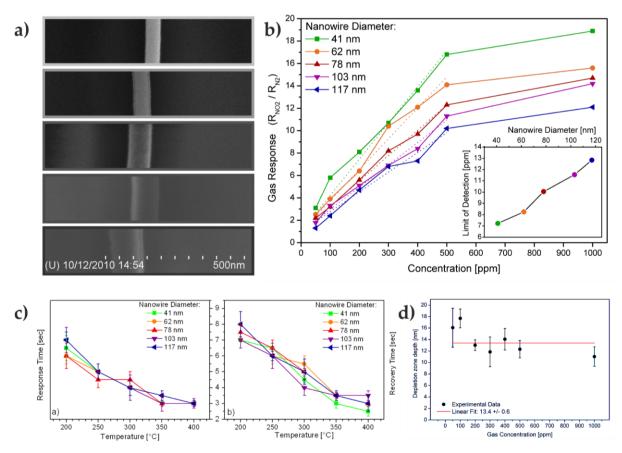


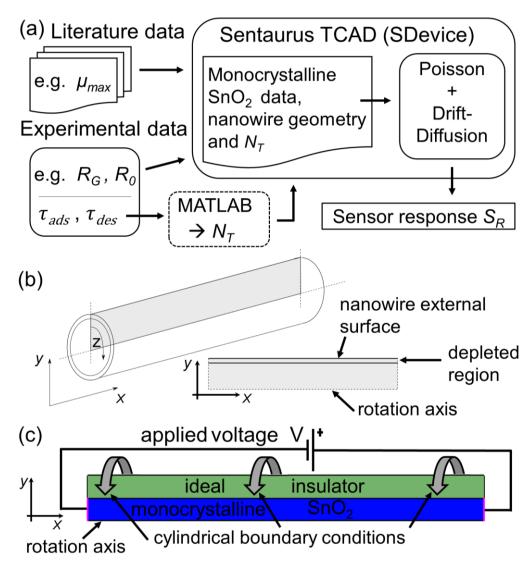
Figure 2: a) SEM images of different nanowires investigated (from bottom to top: 117, 103, 78, 62, and 41 nm). b) Gas responses of the five single-nanowire sensors to NO<sub>2</sub> concentrations ranging from 50 ppm to 1000 ppm at 250 °C (limit of detections are reported in the inset). c) Response and recovery time of the single-nanowire sensors to NO<sub>2</sub>, as a

function of the working temperature. **d)** Depletion zone depth, calculated from the fits of the single-nanowire sensors response *vs.* NO<sub>2</sub> concentrations, taking into consideration the nanowire diameters: the weighted average value obtained was 13.4 nm. Reproduced with permission from Ref. [9].

#### 2.2 Introduction to modelling approaches

We present two modelling approaches described in Section 2.3 and 2.4, respectively. In both cases, we use Sentaurus TCAD (Synopsys Inc., Mountain View - CA, United States of America) to solve the Poisson's and the drift-diffusion equations, and we characterise a new material, namely the monocrystalline SnO<sub>2</sub>, with specific parameters taken both from literature and experimental evidence, as conceptually depicted in Fig. 3a. We model the surface kinetics and NO<sub>2</sub> molecules adsorption through electron traps placed onto the nanowire surface. In particular, in the first approach (see Section 2.3), we obtain the electron trap density by fitting the sensor experimental responses. This demonstrates that modelling the sensing phenomenon with an electron trap density is enough to accurately predict the sensor response, bearing in mind the adsorption mechanism of oxidising gases on the surface of thermoactivated MOX sensors [20]. Then (see Section 2.4), we introduce an analytical link between the electron trap density and the sensor dynamic response, i.e. we derive the electron trap density  $N_T$  from time-dependent experimental results. The dashed box in Fig. 3a highlights the use of a MATLAB (The MathWorks Inc., Natick - MA, United States of America) script to calculate  $N_T$  in the improved model. Fig. 3b schematises the structure of the nanowire and reports its longitudinal 2D section, which is analysed in Sentaurus TCAD. The longitudinal section top face corresponds to the external surface (please note the depleted layer), whereas the bottom face is the nanowire centre axis (rotation axis). Then, we cover the nanowire with an ideal insulator, with relative dielectric permittivity equal to 1.0, in order to create a fictitious material interface. This allows to place interface electron traps onto the nanowire surface in Sentaurus TCAD. The final simulated nanowire structure is displayed in Fig. 3c, which depicts the 2D nanowire simulation domain, covered by the fictitious ideal insulator layer. We repeat the procedure to build nanowires with all the diameters specified in [9], namely 41, 62, 78, 103 and 117 nm. Furthermore, we account for the third dimension through cylindrical boundary conditions applied along the z axis. The simulation of 2D meshes is much more computationally efficient than that of 3D

structures. With this procedure we obtain simulation times from a few seconds to a few minutes on a 4-core machine. We also verified that we obtain identical results with the 2D mesh described above and with 3D nanowire structures of the type of Fig. 3b. Finally, the nanowire response is defined as a resistance ratio, which is length-independent, thus no restraint is required for the nanowire length, which is assumed to be 500 nm in all cases.



**Figure 3: (a)** Methodological approach: the dashed box (MATLAB) refers to the improved model of section 2.4; it is used to extract the number of occupied adsorption sites  $N_T$  that corresponds to the number of traps in the simulation framework. (b) Schematic three-dimensional and cross section view of the considered nanowire structure. (c) Sentaurus model associated with the considered nanowire structure.

#### 2.3 Numerical model with one fitting parameter

In order to accurately model the SnO<sub>2</sub> nanowire response to different NO<sub>2</sub> concentrations at different temperatures, we determine the nanowire electrostatics and transport properties by numerically solving the drift-diffusion equations coupled with the Poisson's one by means of finite element method in Sentaurus. The considered SnO<sub>2</sub> nanowires behave as classical n-type doped semiconductor resistors. Indeed, quantum confinement effects such as conductance quantization are not present for the considered diameters and operating conditions, as experimentally verified in [9].

Moreover, we exploited an ideal insulator covering the nanowire with the only purpose of enabling the placement of interface electron traps used to emulate the presence of adsorbed NO<sub>2</sub> molecules onto the SnO<sub>2</sub> nanowire surface. The trap concentration per surface unit  $N_T$  (i.e. the density of occupied adsorption sites) changes with the NO<sub>2</sub> concentration and with the temperature, leading to the peculiar temperaturedependent and concentration-dependent sensor response. The adsorbed NO<sub>2</sub> molecules (i.e. the electron traps in the model) oxidise the SnO<sub>2</sub> nanowire surface and generate a space charge, that in turn is responsible for the free carrier concentration modulation that leads to the nanowire conductance modulation [28,29]. This mechanism is accounted for in our model by the aforementioned solution of the driftdiffusion and Poisson's equations.

We extract the most important SnO<sub>2</sub> parameters mainly from the literature [30,31] by referring to the specific crystal orientation specified in [9], *i.e.* a nanowire growth direction parallel to [1 0 0] (see Table S1 in the Supplementary Information). Since the sensor response to oxidising gases is usually defined as  $S_R = R_G / R_0$ , where  $R_G$  is the nanowire resistance under exposure to NO<sub>2</sub> and  $R_0$  is the nanowire resistance in inert environment, the SnO<sub>2</sub> parameters influencing the nanowire resistance value are of crucial importance.

In the majority carrier approximation, the resistance of the nanowire can be written as:

$$R = \frac{1}{q n \mu} \frac{L}{A} \tag{1}$$

where *q* is the elementary charge, *n* is the number of free electrons in conduction band,  $\mu$  the electron mobility, *L* the nanowire length and *A* the nanowire cross-section area. Therefore, particular effort should be made in modelling *n* and  $\mu$ . The operating conditions, and the fabrication process as well, strongly impact on the concentration of SnO<sub>2</sub> lattice defects, possibly varying *n* and  $\mu$  by order of magnitudes [32,33]. In addition, the resistance modulation introduced by NO<sub>2</sub> adsorption is mainly related to a variation of free electron density *n* due to the created surface space charge and consequent band bending.

We assume that, at room temperature ( $T_0 = 300$  K), the longitudinal mobility is  $\mu_{max} = 166$  cm<sup>2</sup>V<sup>-1</sup>s<sup>-1</sup>, as calculated by means of *ab initio* techniques for monocrystalline SnO<sub>2</sub> [30]. We approximate the mobility temperature dependence with the one of silicon, *i.e.*,  $\mu(T) = \mu_{max} (T/T_0)^{-2.5}$ , due to the lack of specific information in the literature. Additionally, we calculate *n* to get the same  $R_0$  of the experimental data. In general, it is possible to measure  $\mu$  and extract *n* with a similar procedure.

Finally, as mentioned in section 2.2, we emulate the presence of NO<sub>2</sub> by means of interface electron traps that create a space charge in the nanowire and thus modulate the sensor resistance. In Sentaurus, the electron traps are characterised through their energy level and scattering cross-section, from which the electron-trap scattering probability is evaluated and the conduction properties are calculated. We assume the energy difference between the conduction band edge and the trap energy as calculated in [29] by means of *ab initio* techniques. It corresponds to the desorption energy of NO<sub>2</sub> molecules (the desorption process releases electrons back in the conduction band). Then we set the trap-electron interaction cross-section equal to the average NO<sub>2</sub> molecule steric hindrance, estimated as the van der Waals radius of the NO<sub>2</sub> molecule.

In this first model, we fit the number of traps  $N_T$  to obtain the experimental sensor response as a function of temperature and NO<sub>2</sub> concentration - tables S2 and S3. The purpose is to verify if this computational approach provides reasonable results in terms of accuracy and sensor response prediction capability. Since this is verified (see Section 3), we then eliminate this fitting, as better explained in the next Section.

#### 2.4 Improved numerical model without fitting parameters

The model presented above relies on the fitting of the traps  $N_T$ . In this section, we improve the model by eliminating the fitting on  $N_T$ . We extract  $N_T$  from time-dependent measurements, following the approach reported in [34]. Specifically, according to the first order Langmuir adsorption model [35], and considering the chemistry of NO<sub>2</sub> adsorption reaction, the rate of occupied adsorption sites can be described as:

$$\frac{dN_{occ}(t)}{dt} = k_{ads}[N_{tot} - N_{occ}(t)]C - k_{des}N_{occ}(t)$$
(2)

where  $N_{occ}$  is the number of occupied adsorption sites,  $N_{tot}$  the number of available adsorption sites, *C* the impinging flux of NO<sub>2</sub> molecules onto the nanowire surface, and  $k_{ads}$  and  $k_{des}$  are the two rate constants for the NO<sub>2</sub> adsorption and desorption reactions, respectively. Assuming  $N_{occ}(0) = 0$ , the solution of Equation (2) during the adsorption process reads:

$$N_{occ}(t) = N_{inf} \left( 1 - e^{-t/\tau_{ads}} \right)$$
(3)

where  $N_{inf} = (k_{ads} \ C \ N_{tot})/(k_{ads} \ C + k_{des})$  is the steady state number of occupied adsorption site density, and  $\tau_{ads} = 1/(k_{ads} \ C + k_{des})$  the adsorption time constant. Analogously, during the desorption process, the solution of Equation (2) becomes:

$$\frac{dN_{occ}(t)}{dt} = -k_{des}N_{occ}(t) \quad \Rightarrow \quad N_{occ}(t) = N_{inf} e^{-t/\tau_{des}} \tag{4}$$

where  $\tau_{des} = 1/k_{des}$  is the recovery process time constant.

In general, a single adsorbed NO<sub>2</sub> molecule may trap one to two electrons, dynamically depending also on the adsorption site occupancy and on the working temperature [31]. In order to keep the model complexity low, we assume that each NO<sub>2</sub> molecule corresponds to a single trap, and thus we fix the trap concentration equal to the steady state occupied adsorption site density, i.e.,  $N_T = N_{inf}$ . Therefore, starting from transient measurements, it is possible to derive  $N_{inf}$  as follows. From the recovery process time constant, the desorption rate constant  $k_{des} = 1/\tau_{des}$  is obtained. Then, from the adsorption transient it is possible to obtain the adsorption time constant, from which the adsorption rate constant  $k_{ads}$  is obtained. Notice that *C* is known from experimental setup and  $k_{des}$  is obtained from the desorption transient. Thus, also  $N_{inf} = (k_{ads} C N_{tot}) / (k_{ads} C + k_{des}) = N_T$  can be obtained once  $N_{tot}$  is known. We estimate  $N_{tot}$  by considering the lateral surface orientation of the experimental monocrystalline SnO<sub>2</sub> nanowires [9] and by considering that the possible adsorption sites for NO<sub>2</sub> are on top of Sn atoms [31]. We thus obtain  $N_{tot} = 4.45$  nm<sup>-2</sup>. Even if steric hindrance would prevent additional NO<sub>2</sub> molecules to easily adsorb in a site close to an occupied one

(e.g., a bridging O site if an NO<sub>2</sub> molecule is already adsorbed onto the O atom), we do not account for this phenomenon in our model. Nevertheless, since as aforementioned each NO<sub>2</sub> molecule can trap one to two electrons and since we assume only one electron is trapped for each NO<sub>2</sub> molecule, we believe the two effects to compensate at least partially, thus likely leading to realistic estimations.

The procedure we adopt to obtain  $N_T$  requires the precise extraction from experimental data of exponential transient time constant, which is a challenging task. We perform it in two ways: (1) by considering the logarithm of the measured responses and performing a linear interpolation of the experimental curves, similarly to what was done in Ref. [34]; (2) by estimating the adsorption and desorption time constants by dividing the total transient duration by 5. The proposed procedure relies on the well-known observation that first order time exponential models present only small variations of the order of 0.7% after about 5 times the time constant. The obtained time constants and  $N_T$  values are reported in the Supplementary Information (see Tables S4 and S5).

#### **3 Results and discussion**

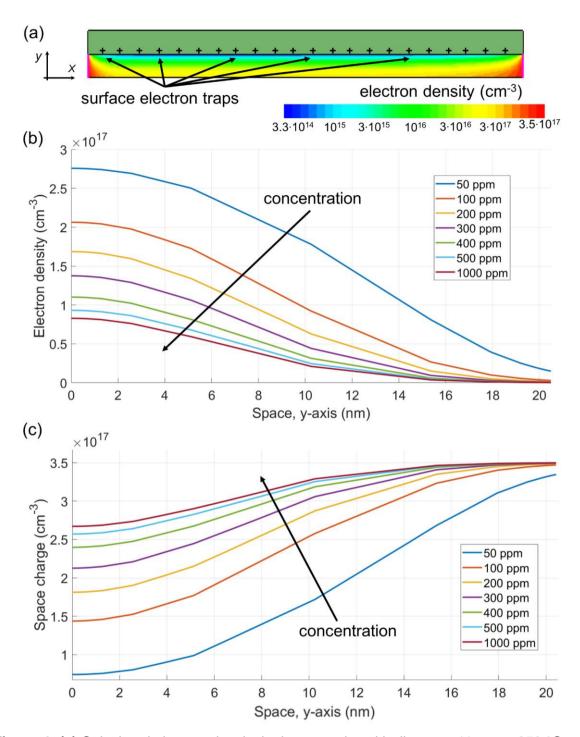
#### 3.1 Sensor current modulation mechanism

The major advantage of simulation-based modelling is that it allows to calculate all the chemical-physical quantities of interest for the analysis of the device (including the space charge, the carrier concentrations, etc.). This enables a deep understanding and performance optimisation of the system investigated.

As a title of example, Fig. 4a reports the electron density in the 41 nm diameter nanowire at 250°C and in presence of 500 ppm of NO<sub>2</sub>. The contour diagram in Fig. 4a shows that the nanowire is strongly depleted on its external surface (light blue), with an electron density of the order of  $10^{15}$  cm<sup>-3</sup>, while it is less depleted in the centre (yellow). This is confirmed in Fig. 4b that reports the electron density in the central cross-section of the nanowire for 500 ppm and for the other considered NO<sub>2</sub> concentrations. The electron density monotonically decreases from the centre (y = 0 nm) to the surface (y = 20.5 nm) of the nanowire for all the considered NO<sub>2</sub> concentrations. Consequently, a positive charge arises in the nanowire because of the electron depletion, and a space charge is created (see Fig. 3(c)). Since the electron density decreases moving from the nanowire centre toward its surface, the space

charge follows the opposite trend by increasing from the nanowire centre toward its surface, according to the depletion level of the nanowire.

This kind of analysis may facilitate the design of the nanowire diameter to optimise the sensor response for a specific application, at a certain temperature and with a certain target concentration, by tuning the extension of the depletion region. Indeed, even though there is a fitting on  $N_T$ , the obtained depletion layer and space charge correspond exactly to the depletion region and space charge induced in the nanowire by the presence of adsorbed NO<sub>2</sub> molecules, which allow to reproduce the sensor response in terms of conductance modulation.



**Figure 4: (a)** Calculated electron density in the nanowire with diameter 41 nm at 250 °C and 500 ppm of NO<sub>2</sub>. The surface electron traps are highlighted for clarity. The picture represents only half of the nanowire and the top line corresponds to the nanowire centre. The green layer is the fictitious insulator covering the nanowire. **(b)** Electron density and **(c)** Space charge density (normalised to -q) with different NO<sub>2</sub> concentrations at 250 °C for the 41 nm diameter nanowire in a cut in *x* direction for x = 250 nm, plotted in function of the nanowire radius (from y = 0 to y = 20.5 nm).

Fig.4c displays the calculated normalised space charge in half nanowire at different NO<sub>2</sub> concentrations at 250 °C, for the 41 nm nanowire. By increasing the NO<sub>2</sub> concentration, hence the density of electron traps, the nanowire depletion increases. With the smallest NO<sub>2</sub> concentration (*i.e.*, 50 ppm), the nanowire is only partially depleted and full depletion is not reached even on the surface (instead, full depletion happens for a normalised space charge of  $3.5 \cdot 10^{17}$  cm<sup>-3</sup>, since this equals the free electron density). This justifies the low sensor response that was found experimentally (see Section 3.2) [9].

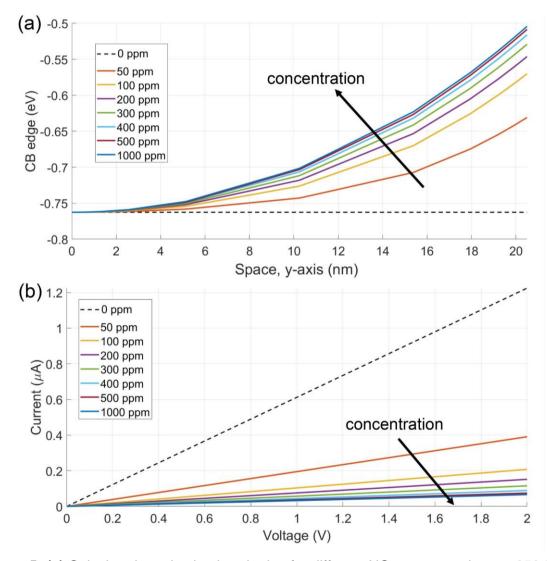
Increasing the NO<sub>2</sub> concentration to 100 ppm is sufficient to fully deplete the nanowire at the surface, leading to an almost doubled sensor response (see Section 3.2).

Furthermore, if we consider the 500 ppm and 1000 ppm concentrations of NO<sub>2</sub>, the nanowire is fully depleted in the range  $\gamma \approx 15.5 \div 20.5$  nm. In contrast to the previous two cases (i.e., 50 and 100 ppm), the space charge profiles are very similar, thus forecasting a small *n* modulation from 500 ppm to 1000 ppm (i.e., small *R*<sub>G</sub> difference and similar sensor response *S*<sub>R</sub>). Fig. 5 verifies our expectations. Specifically, Fig. 5a reports the conduction band edge, whereas Fig. 5b displays the current-voltage characteristics *I*(*V*). Since the space charge is linked to the potential profile, and thus to the conduction band bending, through the Poisson's equation, the small space charge variation obtained for 500 and 1000 ppm reflects in a small conduction band bending difference, that is indeed very similar in the two cases (see Fig. 5a). This corresponds to a small *n* modulation and a small *R*<sub>G</sub> difference, as evident in the similar slopes of the two *I*(*V*) curves shown in Fig. 5b.

These results justify the low increase in experimental response found by increasing the NO<sub>2</sub> concentration above 500 ppm, which is explained through a small space charge variation caused by the saturation of the adsorption site occupancy above 500 ppm of NO<sub>2</sub>, reducing the nanowire capability to significantly increase the resistance  $R_G$  and therefore the response  $S_R$ .

The obtained results could guide the technological design of sensors requiring high sensitivity in a high-NO<sub>2</sub> concentration scenario. If the sensor is fabricated in such a way that it has a low n (e.g., through specific stoichiometric ratios or crystalline defects control [36,37]), it is possible to have large space charge, strong conduction band bending and intense n modulation even with few more adsorbed NO<sub>2</sub> molecules, leading to a good sensor sensitivity even at high NO<sub>2</sub> concentrations. The proposed

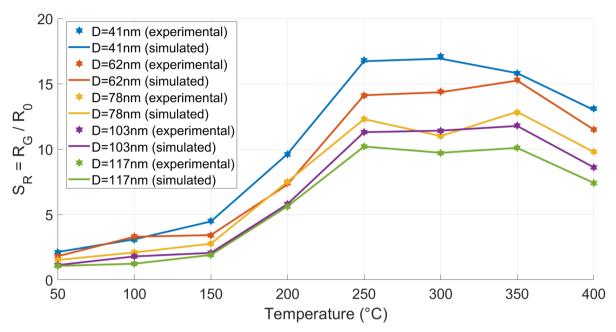
solution represents a simpler route than other approaches that involve more complex technological challenges, such as decreasing the diameter of the nanowire to increase the surface-to-volume ratio and response, which is usually very tricky due to the poor controllability of the nanowire growth. Therefore, the proposed simulation framework simplifies the evaluation of detection technology alternatives.



**Figure 5: (a)** Calculated conduction band edge for different NO<sub>2</sub> concentrations at 250 °C for the 41 nm-diameter nanowire in a cut in *x* direction (for x = 250 nm), as function of the nanowire radius (from y = 0 to y = 20.5 nm). The conduction band edges are shifted to the equilibrium value (dashed curve) to ease the comparison. **(b)** Current-voltage characteristics at 250 °C for different NO<sub>2</sub> concentrations for the 41 nm-diameter nanowire.

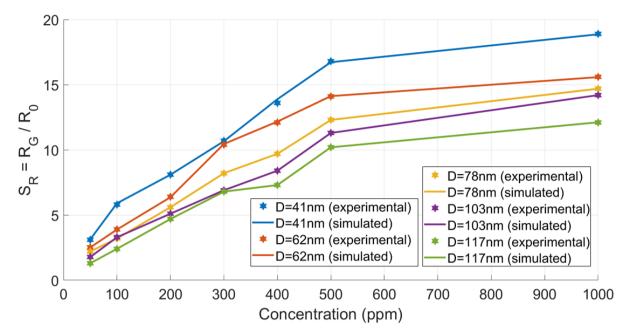
#### 3.2 Numerical modelling with one fitting parameter

Fig. 6 reports the experimental sensor responses  $S_R$  and the ones simulated through the first proposed model (see Section 2.3) as a function of temperature and for different nanowire diameters *D*. The simulated responses are obtained by fitting over  $N_T$  to match the experimental data at each temperature for the five nanowires.



**Figure 6** Experimental and simulated sensor responses as function of temperature and for different nanowire diameters, for a constant NO<sub>2</sub> concentration of 500 ppm.

Fig. 7, instead, displays the calculated sensor responses as a function of NO<sub>2</sub> concentration and the relative experimental data at a fixed temperature of 250°C.

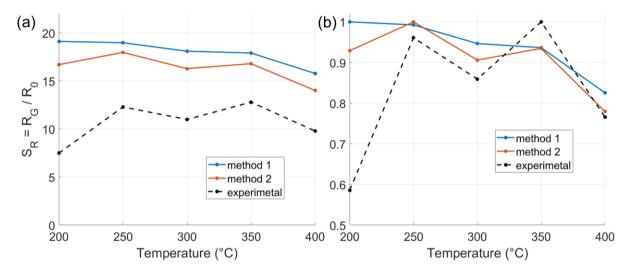


**Figure 7:** Experimental and simulated sensor responses as function of temperature and for different nanowire diameters, at a temperature of 250 °C.

After the  $N_T$  fitting at each temperature and NO<sub>2</sub> concentration, the developed simulation framework is capable of accurately reproducing the sensor response both as a function of the temperature and of the NO<sub>2</sub> concentration, for all the nanowire diameters considered. This means that the usage of interface traps in Sentaurus TCAD is sufficient to accurately reproduce the nanowire surface space charge and the band bending caused by the adsorbed NO<sub>2</sub> molecules. Furthermore, the simulation framework based on the Poisson's and drift-diffusion equations is sufficient to account for the significant physical processes involved. Indeed, the calculated conduction band edge bending, space charge and depletion layer width, accurately correspond to the experimental ones, induced by the adsorption of the NO<sub>2</sub> molecules. Finally, despite the assumption of a silicon-like mobility temperature dependence, the fitting over  $N_T$  proves the employed methodology to be an effective way to provide useful information for design purposes, motivating further work to link the  $N_T$  with the device physics, eventually removing the need for fitting over  $N_T$ .

#### 3.3 Improved model without fitting parameters

In order to eliminate the fitting over  $N_T$ , time transient measurements of both the sensing (adsorption) process and the recovery (desorption) process were used. Indeed, as explained in Section 2.4,  $N_T$  can be derived from  $\tau_{ads}$  and  $\tau_{des}$ . The timedependent experimental data available in [9] are relative only to the nanowire with diameter D = 78 nm measured at 500 ppm of NO<sub>2</sub>. Furthermore, only a limited temperature range is reported, i.e. between 200°C and 400°C. Fig. 8a and 8b report the calculated sensor responses using the improved model (see Section 2.4). Despite the limited amount of available experimental data, the trend of the computational results obtained with the improved model are in good agreement with the experimental data.



**Figure 8: (a)** Experimental and simulated sensor response, following two methods for the estimation of the time constants, as function of the temperature, for D = 78 nm and a constant NO<sub>2</sub> concentration of 500 ppm. **(b)** Experimental and simulated sensor responses (normalised), following two methods for the estimation of the time constants, as a function of temperature, for D = 78 nm and a constant NO<sub>2</sub> concentration of 500 ppm.

The procedure we adopt to obtain  $N_T$  requires the precise extraction from experimental data of exponential transient time constant. As described in Section 2.4, we evaluate the time constants  $\tau_{ads}$  and  $\tau_{des}$  following two different methods, namely a linear interpolation of the (logarithmic) experimental curves and an estimation from the transient duration. Both methods lead to comparable results in terms of accuracy, compared to the experimental data, and predicted response. However, the second method shows a slightly better matching with experimental data.

Even though the time constants obtained with the two methods are similar (see Table S4), there are significant differences on  $N_T$  and thus on the final response. In both cases, the simulated responses are about 1.5 times the experimental ones (see Fig. 8a). Furthermore, by observing the results in Fig. 8b, the simulated responses suffer

also of a compressed variation range compared to the experimental one. We attribute the origin of the discrepancy between the calculated and the experimental responses to the following facts:

(a) in our model we assume ideal monocrystalline SnO<sub>2</sub>, whereas in reality, nanostructures have many defects which can vary  $N_{tot}$  and thus  $N_T$  and the final response;

(b) the assumption that each adsorbed NO<sub>2</sub> molecule traps only one electron can influence  $N_T$ , that might significantly differ from  $N_{inf}$ ,

(c) the experimental response and recovery times are influenced by the volume and shape of the measurement chamber, and the error on the estimation of the response and recovery time constants influences  $N_{\tau}$ ;

(d) the lack of experimental knowledge about some monocrystalline SnO<sub>2</sub> material parameters for the specific nanowires used, especially on *n* and  $\mu$  (and its temperature dependence), impacts on the system electronic electrostatics and transport properties. To improve and further optimise the model, a more precise assessment of  $N\tau$  is necessary. To this aim, a dedicated work will be carried out, in which experiments will be conducted to obtain a more accurate extraction of  $\tau_{ads}$  and  $\tau_{des}$  parameters, as well as further characterisations in order to measure the main material parameters needed as inputs in the simulations, without relying on literature data of analogous nanostructures.

#### **4** Conclusions

In this work, we presented a modelling approach of MOX-based single-nanowire gas sensors based on finite-element simulations, in which we modelled the effects of an oxidising gas through surface electron traps. We initially demonstrated that the simulation framework used is capable of accurately modelling and reproducing the experimental responses of SnO<sub>2</sub> nanowires, with diameters ranging from 41 to 117 nm to different NO<sub>2</sub> concentrations at different temperatures. In order to perform this analysis, we used a fitting over the trap concentration, representing the density of adsorbed NO<sub>2</sub> molecules onto the nanowires.

Then, we improved the model by eliminating the fitting over the trap concentration, instead extracting it from time-dependent experimental results. This improved model provided a good match with the experimental results. We believe that most of the

differences can be overcome through additional and more refined experimental results, which, for instance, could include a larger number of devices, improved electrical contacts, and larger temperature and/or NO<sub>2</sub> concentration ranges.

Therefore, a first objective of future work should be a refinement of the model, in order to estimate more accurately the number of traps. Experiments and *ab initio* calculations, whose results can be easily integrated into the proposed simulation framework, can also be employed for this purpose.

This work demonstrates that the presented methodology is able to capture the main physical-chemical phenomena contributing to the sensing performance of MOX-based sensors. Thus, in principle, it can be extended from single nanowires to also other geometries of monocrystalline sensors, thanks to the model capability of accurately predicting internal quantities such as the conduction band edge bending, the space charge and the width of the depletion layer. This work motivates further research about the direct calculation of the quantities that are currently still derived from experiments, and specific measurement should be performed to determine the temperature dependence of monocrystalline SnO<sub>2</sub> mobility, as well as to estimate more precisely the time constants.

Finally, the model can be used to determine the sensor parameters (e.g. processing/manufacturing conditions and/or geometrical constraints) that influence the sensing performance, thus enabling optimised engineering of future gas sensing devices.

#### Acknowledgments

The present work has been supported by Koral Technologies Srl (Trento, Italy).

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### Modelling electronic transport in monocrystalline metal oxide gas sensors: from the surface kinetics to the experimental response

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#### **Supplementary Information**

**TABLE S1.** Monocrystalline SnO<sub>2</sub> material electrical parameter values used to perform the simulations. Optical parameters are not reported.

Parameter	Value	Notes
relative permittivity	2.28	isotropic approximation, it is in the range 2.26÷2.30, from [SR1]
lattice heat capacity	2.45 J K <sup>-1</sup> cm <sup>-3</sup>	from [SR2]
lattice thermal conductivity	0.765 W m <sup>-1</sup> K <sup>-1</sup>	isotropic approximation (average), from [SR3]
band gap	3.74 eV	from [SR4]
electron affinity	5.73 eV	in the range 4.04÷5.73 eV depending on crystal orientation, from [SR5]
electron DOS effective mass	0.26	for longitudinal direction only, from [SR6]
hole DOS effective mass	1.27	for longitudinal direction only, from [SR6]
electron mobility	166 cm <sup>2</sup> V <sup>-1</sup> s <sup>-1</sup>	for longitudinal direction only, from [SR6]
hole mobility Dmax,h	15.7 cm <sup>2</sup> V <sup>-1</sup> s <sup>-1</sup>	for longitudinal direction only, from [SR6]
mobility dependence with temperature	$\Box(T) = \\ \Box_{\max}(T/T_0)^{-A}$	assuming $A = 2.5$ (electrons), 2.2 (holes), typical values for monocrystalline Si, $T_0 = 300$ K

**TABLE S2.** Activated surface trap concentrations used in the finite-element simulations with one fitting parameter, for different nanowire diameters. The temperature is varied from 50 to 400 °C, whereas the NO<sub>2</sub> concentration is fixed at 500 ppm. The trap concentrations  $N_T$  are expressed in cm<sup>-2</sup>, only the active traps are reported; they are recovered from the induced space charge through spatial integral.

Temperature	41 nm	62 nm	78 nm	103 nm	117 nm
50 °C	2.52·10 <sup>11</sup>	2.91·10 <sup>11</sup>	2.49·10 <sup>11</sup>	1.06·10 <sup>11</sup>	6.20·10 <sup>10</sup>
100 °C	3.56·10 <sup>11</sup>	5.22·10 <sup>11</sup>	4.11·10 <sup>11</sup>	4.48·10 <sup>11</sup>	2.03·10 <sup>11</sup>
150 °C	4.45·10 <sup>11</sup>	5.42·10 <sup>11</sup>	5.45·10 <sup>11</sup>	5.44·10 <sup>11</sup>	5.64·10 <sup>11</sup>
200 °C	5.79·10 <sup>11</sup>	7.73·10 <sup>11</sup>	9.41·10 <sup>11</sup>	1.11·10 <sup>12</sup>	1.24·10 <sup>12</sup>
250 °C	6.40·10 <sup>11</sup>	9.01·10 <sup>11</sup>	1.05·10 <sup>12</sup>	1.36·10 <sup>12</sup>	1.50·10 <sup>12</sup>
300 °C	6.43·10 <sup>11</sup>	9.06·10 <sup>11</sup>	1.05·10 <sup>12</sup>	1.37·10 <sup>12</sup>	1.48·10 <sup>12</sup>
350 °C	6.40·10 <sup>11</sup>	9.17·10 <sup>11</sup>	1.09·10 <sup>12</sup>	1.39·10 <sup>12</sup>	1.50·10 <sup>12</sup>
400 °C	6.26·10 <sup>11</sup>	8.76·10 <sup>11</sup>	1.03·10 <sup>12</sup>	1.29·10 <sup>12</sup>	1.39·10 <sup>12</sup>

**TABLE S3.** Activated surface trap concentrations used in the finite-element simulations with one fitting parameter, for different nanowire diameters. The NO<sub>2</sub> concentration is varied from 50 to 1000 ppm, whereas the temperature is fixed at 250 °C. The trap concentrations  $N_T$  are expressed in cm<sup>-2</sup>, only the active traps are reported; they are recovered from the induced space charge through spatial integral.

Concentration	41 nm	62 nm	78 nm	103 nm	117 nm
50 ppm	3.79 <b>.</b> 10 <sup>11</sup>	4.44·10 <sup>11</sup>	4.50·10 <sup>11</sup>	4.55•10 <sup>11</sup>	2.57·10 <sup>11</sup>
100 ppm	5.10·10 <sup>11</sup>	5.97·10 <sup>11</sup>	6.17·10 <sup>11</sup>	8.15·10 <sup>12</sup>	7.36·10 <sup>11</sup>
200 ppm	5.60•10 <sup>11</sup>	7.44·10 <sup>11</sup>	8.44·10 <sup>11</sup>	1.05·10 <sup>12</sup>	1.15·10 <sup>12</sup>
300 ppm	5.96·10 <sup>11</sup>	8.52·10 <sup>11</sup>	9.68·10 <sup>11</sup>	1.19·10 <sup>12</sup>	1.33·10 <sup>12</sup>
400 ppm	6.23·10 <sup>11</sup>	8.78·10 <sup>11</sup>	1.02·10 <sup>12</sup>	1.27·10 <sup>12</sup>	1.37·10 <sup>12</sup>
500 ppm	6.40·10 <sup>11</sup>	9.01·10 <sup>11</sup>	1.05·10 <sup>12</sup>	1.36·10 <sup>12</sup>	1.50·10 <sup>12</sup>
1000 ppm	6.50·10 <sup>11</sup>	9.15·10 <sup>11</sup>	1.12·10 <sup>12</sup>	1.43·10 <sup>12</sup>	1.56·10 <sup>12</sup>

**TABLE S4.** Adsorption and desorption time constants, expressed in s, calculated according to the two proposed methods, i.e. linear interpolation (subscript "li") and estimation from the transient duration (subscript "td"). The NO<sub>2</sub> concentration is fixed at 500 ppm, whereas the temperature is varied in the range  $200 \div 400$  °C. The nanowire diameter is D = 78 nm.

	Time constants (s)			
Temperature	$ au_{ads,li}$	$ au_{des,li}$	$ au_{ads,td}$	$ au_{des,td}$
200 °C	2.54	3.11	1.69	2.41
250 °C	1.96	2.14	1.14	2.10
300 °C	1.33	1.87	1.33	1.95
350 °C	0.91	1.05	1.12	1.85
400 °C	0.61	1.32	1.33	1.68

**TABLE S5.** Surface trap concentrations, expressed in cm<sup>-2</sup>, calculated according to the two proposed methods, i.e. linear interpolation (subscript "li") and estimation from the transient duration (subscript "td"). The NO<sub>2</sub> concentration is fixed at 500 ppm, whereas the temperature is varied in the range 200÷400 °C. The considered nanowire diameter is D = 78 nm. Only the active traps are reported; they are recovered from the induced space charge through spatial integral.

	Surface trap concentrations		
Temperature	NT,li NT,td		
200 °C	1.156·10 <sup>12</sup>	1.134·10 <sup>12</sup>	
250 °C	1.165·10 <sup>12</sup>	1.154·10 <sup>12</sup>	
300 °C	1.157·10 <sup>12</sup>	1.137·10 <sup>12</sup>	
350 °C	1.159·10 <sup>12</sup>	1.15·10 <sup>12</sup>	
400 °C	1.14·10 <sup>12</sup>	1.12·10 <sup>12</sup>	

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